

**International Journal of Current
Microbiology and Applied Sciences
(IJCMAS) NAAS RATING-5.38, ICV-95.39**
ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online)

**An International, Monthly, Online, Free Access, Peer Reviewed,
Indexed, fast track Scientific Research Journal**

Certificate of Publication

This is to certify that the following article reviewed by editorial board and published in International Journal of Current Microbiology and Applied Sciences (IJCMAS) ISSN: 2319-7692 (Print) ISSN 2319-7706 (Online).

Int.J.Curr.Microbiol.App.Sci.2018.7.(5):905-911

<https://doi.org/10.20546/ijcmas.2018.705.110>

Comparative Study of Boron Accumulation in Flag Leaf, Spike and Grain of Wheat (*Triticum aestivum* L.) Grown under Heat Stress

Satish Kumar¹, Rajeev Kumar¹, Pankaj Kumar¹ and Santosh Kumar Singh²

¹Department of Agricultural Biotechnology and Molecular Biology

²Department of soil science, DRPCAUI, Pusa, Bihar – 848125, India



Dr. M. Prakash
Editor-in-chief

International Journal of Current Microbiology and Applied Sciences

www.ijcmas.com

www.excellentpublishers.com



© International Journal of Current Microbiology and Applied
Sciences (IJCMAS)

www.excellentpublishers.com www.ijcmas.com